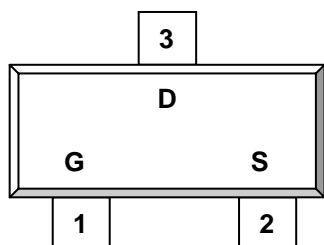


# ST2305A

## DESCRIPTION

ST2305A is the P-Channel logic enhancement mode power field effect transistor which is produced using high cell density, DMOS trench technology. This high density process is especially tailored to minimize on-state resistance. These devices are particularly suited for low voltage application such as cellular phone and notebook computer power management, other battery powered circuits, and low in-line power loss are required. The product is in a very small outline surface mount package.

## PIN CONFIGURATION SOT-23-3L

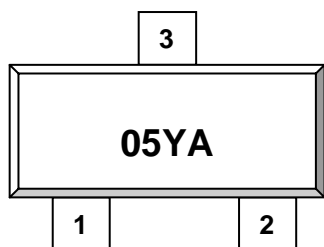


1.Gate 2.Source 3.Drain

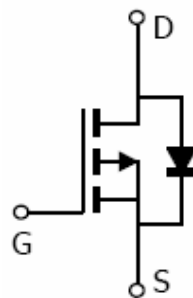
## FEATURE

- -15V/-3.5A,  $R_{DS(ON)} = 45\text{m-ohm}$  (Typ.) @VGS = -4.5V
- -15V/-3.0A,  $R_{DS(ON)} = 55\text{m-ohm}$  @VGS = -2.5V
- -15V/-2.0A,  $R_{DS(ON)} = 90\text{m-ohm}$  @VGS=-1.8V
- Super high density cell design for extremely low  $R_{DS(ON)}$
- Exceptional on-resistance and maximum DC current capability
- SOT-23-3L package design

## PART MARKING SOT-23-3L



Y: Year Code A: Process Code



## ORDERING INFORMATION

Part Number	Package	Part Marking
ST2305AS23RG	SOT-23-3L	05YA

※ Process Code : A ~ Z ; a ~ z

※ ST2305AS23RG S : SOT-23-3L ; R : Tape Reel ; G : Pb – Free

## ST2305A

**ABSOLUTE MAXIMUM RATINGS** (Ta = 25°C Unless otherwise noted )

Parameter	Symbol	Typical	Unit
Drain-Source Voltage	V <sub>DSS</sub>	-15	V
Gate-Source Voltage	V <sub>GSS</sub>	±12	V
Continuous Drain Current (T <sub>J</sub> =150°C)	I <sub>D</sub>	T <sub>A</sub> =25°C -3.5	A
		T <sub>A</sub> =70°C -2.8	
Pulsed Drain Current	I <sub>DM</sub>	-10	A
Continuous Source Current (Diode Conduction)	I <sub>S</sub>	-1.6	A
Power Dissipation	P <sub>D</sub>	T <sub>A</sub> =25°C 1.25	W
		T <sub>A</sub> =70°C 0.8	
Operation Junction Temperature	T <sub>J</sub>	150	°C
Storage Temperature Range	T <sub>STG</sub>	-55/150	°C
Thermal Resistance-Junction to Ambient	R <sub>θJA</sub>	120	°C/W

## ST2305A

## ELECTRICAL CHARACTERISTICS ( Ta = 25°C Unless otherwise noted )

Parameter	Symbol	Condition	Min	Typ	Max	Unit
<b>Static</b>						
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS}=0V, I_D=-250\mu A$	-15			V
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=-250\mu A$	-0.3		-1.5	V
Gate Leakage Current	$I_{GSS}$	$V_{DS}=0V, V_{GS}=\pm 12V$			$\pm 100$	nA
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS}=-20V, V_{GS}=0V$			-1	uA
		$V_{DS}=-20V, V_{GS}=0V$ $T_J=55^\circ C$			-10	
On-State Drain Current	$I_{D(on)}$	$V_{DS}\leq -5V, V_{GS}=-4.5V$	-6			A
		$V_{DS}\leq -5V, V_{GS}=-2.5V$	-3			
Drain-source On-Resistance	$R_{DS(on)}$	$V_{GS}=-4.5V, I_D=-3.5A$ $V_{GS}=-2.5V, I_D=-2.0A$ $V_{GS}=-1.8V, I_D=-2.0A$		0.045 0.055 0.09		$\Omega$
Forward Transconductance	$g_{fs}$	$V_{DS}=-5V, I_D=-3.5V$		8.5		S
Diode Forward Voltage	$V_{SD}$	$I_S=-1.6A, V_{GS}=0V$		-0.8	-1.2	V
<b>Dynamic</b>						
Total Gate Charge	$Q_g$	$V_{DS}=-10V$ $V_{GS}=-4.5V$ $I_D=-3.5A$		10	12	nC
Gate-Source Charge	$Q_{gs}$			2		
Gate-Drain Charge	$Q_{gd}$			2		
Input Capacitance	$C_{iss}$	$V_{DS}=-10V$ $V_{GS}=0V$ $F=1MHz$		485		pF
Output Capacitance	$C_{oss}$			90		
Reverse Transfer Capacitance	$C_{rss}$			40		
Turn-On Time	$t_{d(on)tr}$	$V_{DD}=-10V$ $R_L=6\Omega$ $I_D=-1.0A$ $V_{GEN}=-4.5V$ $R_G=6\Omega$		10	18	nS
				13	22	
Turn-Off Time	$t_{d(off)tf}$			18	24	
				15	20	